

**Search Notes**

Application/Control No.

09/527,761

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

BARKER ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
483	15,16	11/21/2005	SHL
483	401,462	11/21/2005	SHL
483	975	11/21/2005	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as	Above	11/21/2005	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/494(see printouts)	11/21/2005	SHL
257/797 (see printouts)	11/21/2005	SHL
NPL	11/21/2005	SHL